COMPLIANT

HALOGEN

FREE





PowerPAK ChipFET Dual

Dual P-Channel 30 V (D-S) MOSFET

PRODU	CT SUMMARY		
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)
- 30	$0.054 \text{ at V}_{GS} = -10 \text{ V}$	- 6 ^a	4.8 nC
- 30	0.088 at $V_{GS} = -4.5 \text{ V}$	- 6 ^a	4.6110

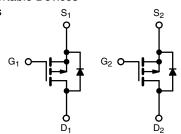
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- New Thermally Enhanced PowerPAK[®] ChipFET[®] Package
 - Small Footprint Area
 - Low On-Resistance
 - Thin 0.8 mm Profile
- 100 % R_q Tested
- Compliant to RoHS Directive 2002/95/EC



- · Load Switch for Portable Devices
- DC/DC Converters

Lot Traceability and Date Code



Ordering Information: Si5997DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

Bottom View

P-Channel MOSFET P-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	- 30	V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		- 6 ^a		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C	_	- 6 ^a	1	
Continuous Diain Current (1) = 130 C)	T _A = 25 °C	I _D	- 5.1 ^{b, c}		
	T _A = 70 °C		- 4.1 ^{b, c}	Α	
Pulsed Drain Current (t = 300 μs)		I _{DM}	- 25	1	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	- 6 ^a	1	
Continuous Gource-Drain Diode Guirent	T _A = 25 °C	'5	- 1.9 ^{b, c}		
	T _C = 25 °C		10.4		
Maximum Power Dissipation	T _C = 70 °C	P _D	6.7	w	
Maximum Fower Dissipation	T _A = 25 °C	' Б	2.3 ^{b, c}	7 **	
	T _A = 70 °C		1.5 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260	7	

Marking Code

Part # Code

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R_{thJA}	43	55	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	9.5	12	0/ **

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. See solder profile (www.vishay.com/ppg?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 105 °C/W.



SPECIFICATIONS (T _J = 25 °C, unless otherwise noted) Parameter Symbol Test Conditions Min. Typ. Max.						
Static	Symbol	rest conditions	IVIIII.	тур.	IVIAX.	Unit
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 30		<u> </u>	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	VGS = 0 V, ID = 200 ft. V	- 00	- 22		· ·
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		4.1		mV/°C
Gate-Source Threshold Voltage	` '	V _{DS} = V _{GS} , I _D = - 250 μA	- 1.2	4.1	- 2.4	V
	V _{GS(th)}	$V_{DS} = V_{GS}, V_{GS} = \pm 20 \text{ V}$	- 1.2			-
Gate-Source Leakage	I _{GSS}	$V_{DS} = -30 \text{ V}, V_{GS} = \pm 20 \text{ V}$ $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			- 1 - 10	μΑ
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 20			Α
O. Clare D.a. Carren		V _{GS} = - 10 V, I _D = - 3 A		0.045	0.054	Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 1 A		0.072	0.088	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 3 A		7		S
Dynamic ^b	•					
Input Capacitance	C _{iss}			430		
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		90		pF
Reverse Transfer Capacitance	C _{rss}			70		
Tabal Oata Ohamus	Qg	V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 5.1 A		9.5	14.5	nC
Total Gate Charge				4.8	7.5	
Gate-Source Charge	Q_{gs}	V _{DS} = - 15 V, V _{GS} = - 4.5 V, I _D = - 5.1 A		1.6		
Gate-Drain Charge	Q_{gd}			2.2		
Gate Resistance	R_{g}	f = 1 MHz	2	8	16	Ω
Turn-On Delay Time	t _{d(on)}			35	70	
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 3.7 \Omega$		25	50	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 4.1 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		17	35	- ns
Fall Time	t _f			10	20	
Turn-On Delay Time	t _{d(on)}			10	20	
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 3.7 \Omega$		10	20	
Turn-Off Delay Time	t _{d(off)}	$I_{D} \cong -4.1 \text{ A}, V_{GEN} = -10 \text{ V}, R_{g} = 1 \Omega$		20	40	
Fall Time	t _f			10	20	
Drain-Source Body Diode Characteristi	cs			•		
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 6	
Pulse Diode Forward Current	I _{SM}				- 25	A
Body Diode Voltage	V _{SD}	I _S = - 4.1 A, V _{GS} = 0 V		- 0.85	- 1.2	٧
Body Diode Reverse Recovery Time	t _{rr}			15	30	ns
Body Diode Reverse Recovery Charge	Q _{rr}	1 4 A dl/dt 100 A/:- T 05 00		8	15	nC
Reverse Recovery Fall Time	t _a	$I_F = -4 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		10.5		
Reverse Recovery Rise Time	t _b	1		4.5		ns

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

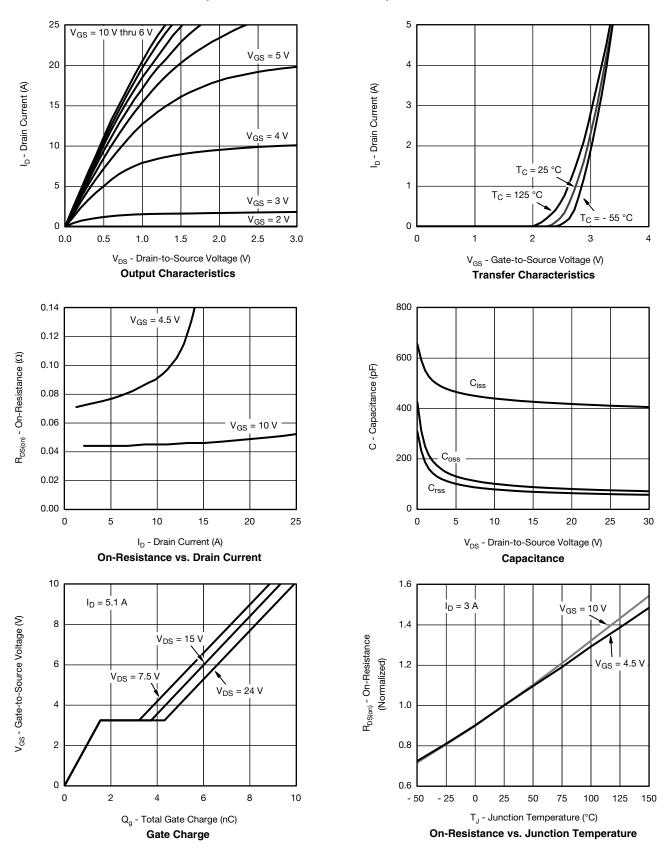
b. Guaranteed by design, not subject to production testing.



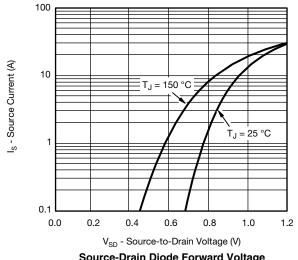


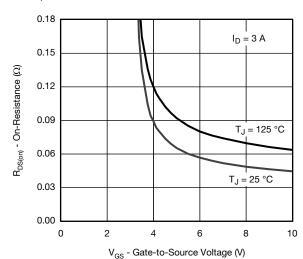


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



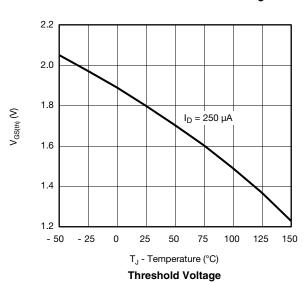
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

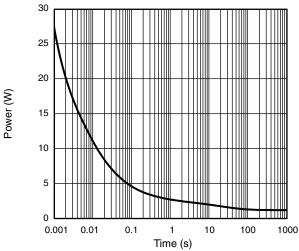




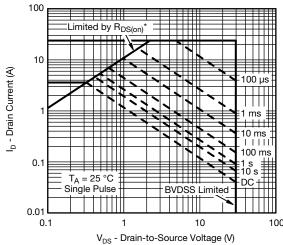
Source-Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage





Single Pulse Power, Junction-to-Ambient



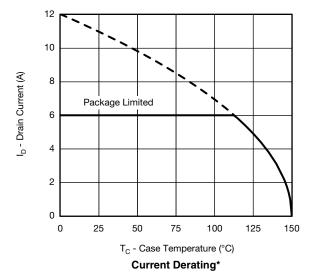
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

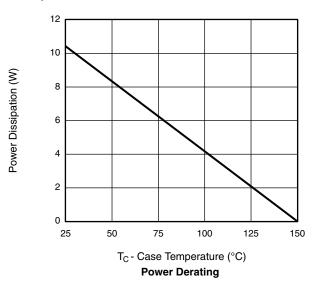
Safe Operating Area, Junction-to-Ambient





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

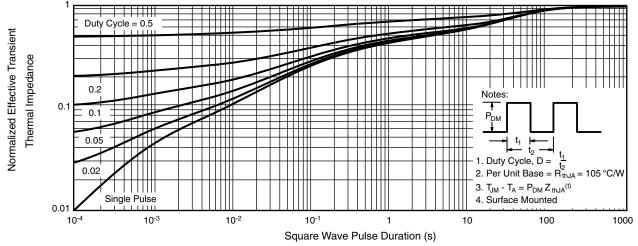




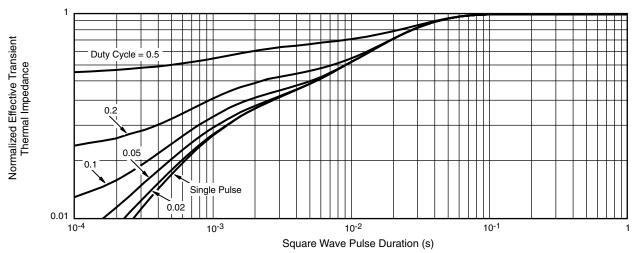
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

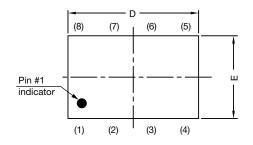


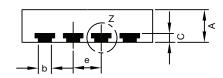
Normalized Thermal Transient Impedance, Junction-to-Case

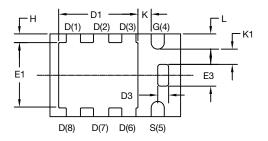
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?67186.



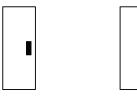
PowerPAK® ChipFET® Case Outline







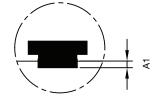
Backside view of single pad



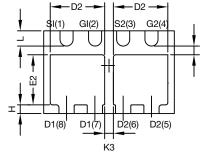
Side view of single



Side view of dual



Detail Z



Backside view of dual pad

DIM.	MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.70	0.75	0.85	0.028	0.030	0.033	
A1	0	-	0.05	0	-	0.002	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	2.92	3.00	3.08	0.115	0.118	0.121	
D1	1.75	1.87	2.00	0.069	0.074	0.079	
D2	1.07	1.20	1.32	0.042	0.047	0.052	
D3	0.20	0.25	0.30	0.008	0.010	0.012	
E	1.82	1.90	1.98	0.072	0.075	0.078	
E1	1.38	1.50	1.63	0.054	0.059	0.064	
E2	0.92	1.05	1.17	0.036	0.041	0.046	
E3	0.45	0.50	0.55	0.018	0.020	0.022	
е		0.65 BSC		0.026 BSC			
Н	0.15	0.20	0.25	0.006	0.008	0.010	
K	0.25	-	-	0.010	-	ı	
K1	0.30	-	-	0.012	-	ı	
K2	0.20	-	-	0.008	-	ı	
K3	0.20	-	-	0.008	-	ı	
L	0.30	0.35	0.40	0.012	0.014	0.016	

C14-0630-Rev. E, 21-Jul-14

Note

DWG: 5940

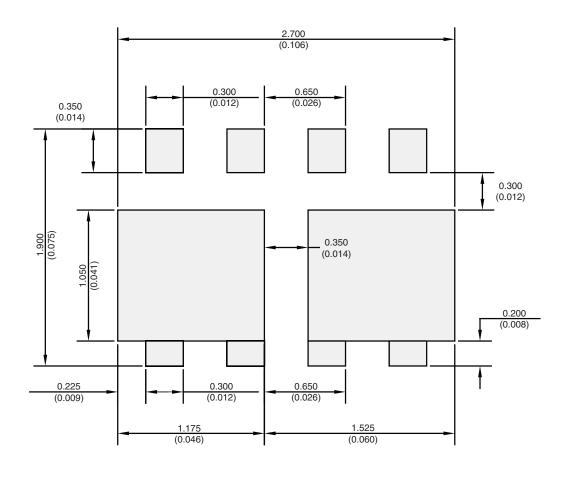
Revision: 21-Jul-14

• Millimeters will govern

Z



RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Dual



Recommended Minimum Pads Dimensions in mm/(Inches)

Note: This is Flipped Mirror Image Pin #1 Location is Top Left Corner

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